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10/509,398	10/03/2005	Christopher James Philip Clements	M02B124	5844
71134 Edwards Vacuu	7590 05/27/200 im, Inc.	EXAMINER		
	COLLEGE BOULEV	WU, IVES J		
SANTA CLAR	A, CA 95054		ART UNIT	PAPER NUMBER
			1797	
			MAIL DATE	DELIVERY MODE
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)		
	10/509,398	CLEMENTS ET AL.		
Office Action Summary	Examiner	Art Unit		
	IVES WU	1797		
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet with the o	correspondence address		
A SHORTENED STATUTORY PERIOD FOR REPL WHICHEVER IS LONGER, FROM THE MAILING D - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION (36(a). In no event, however, may a reply be till will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDONE	N. mely filed the mailing date of this communication. ED (35 U.S.C. § 133).		
Status				
1) Responsive to communication(s) filed on 25 N	action is non-final. nce except for formal matters, pre			
Disposition of Claims				
4)	wn from consideration.			
Application Papers				
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) accomplicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Example 11.	epted or b) objected to by the drawing(s) be held in abeyance. Se tion is required if the drawing(s) is ob	e 37 CFR 1.85(a). ejected to. See 37 CFR 1.121(d).		
Priority under 35 U.S.C. § 119				
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 				
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:	ate		

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DETAILED ACTION

(1). Applicants' Amendments and Remarks filed on 3/25/2009 have been received. Claims 1, 8, 11, 18 and 20 are amended.

Total cancelled claims are 6-7, 9, 12, 19, 22, 24 and 28 are cancelled.

The objection of claims 27-28 in prior Office Action dated 9/25/2008 is withdrawn in view of the current Amendments.

Accordingly, the rejections of claims 6-7, 9, 12, 19, 22, 24 and 28 in prior Office Action are withdrawn.

The rejections of claims 1 and 18 are revised in response to the current Amendments and presented together with rest of claims in the following.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

- 1. Determining the scope and contents of the prior art.
- 2. Ascertaining the differences between the prior art and the claims at issue.
- 3. Resolving the level of ordinary skill in the pertinent art.
- 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.
- (2). Claims 1-5, 18, 21 and 25-27 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sachweh et al (US 6284022B1).

As to step of contacting the gas stream with water at a temperature of at least 30 °C in a method of scrubbing a halogen-containing gas stream in **independent claim 1**, and water temperature of at least 35 °C in **claim 2**, and water to be in liquid state in **claim 3**, gas stream being contact with water vapour in **claim 4**, the gas stream being contact with water at a temperature of from 35 °C to 80 °C in **claim 5**, Sachweh et al (US 6284022B1) disclose method for removing contaminants from a gas stream (Title). It

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relates to methods for removing gaseous contaminants and aerosols from a vaporsaturated gas stream in a scrubber column, with a scrubbing liquid, the temperature of which is lower by at least 2° C than the temperature of the gas stream, resulting in the formation of a vapor phase (Abstract). Gas streams which are suitable are in principle all gas streams which have a carrier gas which is to be cleaned at the process temperature and which contains both gaseous and particulate contaminants which are to be removed (Col. 2, line 58-61). Suitable scrubbing liquids are, for example, distilled water, demineralized water, tap water, process water, aqueous solutions of acids or bases, or organic solvents such as toluol, butanol, ethanol or acetone (Col. 3, line 55-58). For example, if water is used as scrubbing liquid, it is then possible to remove, for example, the hydrohalic acids, HF, HCl or HBr, from the gas stream without problems (Col. 2, line 3-6). In principle, all scrubber columns in which the necessary contact surface is available are suitable (Col. 4, line 44-45). The temperature of the gas stream when it enters the column may be up to approximately 100 °C. In a preferred embodiment, the temperature of the gas stream is approximately 40 to approximately 90 °C (Col. 4, line 58-61). The temperature of the scrubbing liquid should be lower than the temperature of the gas stream. In a preferred embodiment, the temperature of the scrubbing liquid lies at least approximately 10 to approximately 15 °C below the temperature of the gas stream. Examples of temperature differences which are particularly preferred are approximately 30 to approximately 60 °C., in particularly approximately approximately 40 to approximately 50 °C. In a preferred embodiment, the scrubbing liquid is at a temperature of from approximately 2 to approximately 50 °C (Col. 4, line 64 – Col. 5, line 8).

As to gas stream being subject to at least one further treatment step comprising contacting the gas stream with water at a temperature of less than 30 °C in **independent claim 1**, in view of the temperature range of scrubbing water disclosed by Sachweh et al (US06284022B1), it would be obvious to have second scrubber with water temperature less than 30 °C together because purifying an old product renders obvious. *In re Cofer*, 354 F.2d 664, 148 USPQ 268 (CCPA 1966).

As to a hot wash scrubbing chamber, halogen-containing gas stream water temperature, outlet from hot wash chamber for treated gas in an apparatus in

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independent claim 18, the disclosure of Sachweh et al is incorporated herein by reference, the most subject matters as currently claimed has been recited in applicants' claim 1 and has been discussed therein. Furthermore, Sachweh et al (US 6284022B1) disclose the Figure 2 showing a scrubber column, a vapor-saturated gas stream enters at the bottom end of column and cold scrubber liquid is fed to the top end of the column, an outlet at bottom of the scrubber column (not numbered) which read on the limitations of instant claim, and it would contain a source of halogen-containing gas, a water supply device in order to supply to the scrubber.

As to the apparatus for scrubbing a halogen from a gas stream in **independent** claim 18, the intended use is not considered as limitation.

As to a cold wash scrubbing chamber downstream of hot wash scrubbing chamber, a cold water spray, water temperature in **independent claim 18**, the disclosure of Sachweh et al is incorporated herein by reference, the most subject matters as currently claimed, has been recited in applicants' claim 1, and has been discussed therein. Furthermore, it would be obvious to have 2nd scrubbing stage for water temperature less than 30 °C because duplication in parts. *In re Harza, 274 F.2d 669, 124 USPQ 378 (CCPA 1960)*.

As to a communication pathway for transport of the treated gas from the outlet of hot wash chamber into the old wash chamber, and an outlet for treated gas from cold wash chamber in **independent claim 18**, Sachweh et al (US 6284022B1) disclose the segments in scrubber column in Figure 2, which would have a communication pathway between hot and cold scrubbing if 2nd cold stage of scrubbing is installed. As illustrated in Figure 2, there is an outlet for treated gas (not numbered).

As to fluorine-containing gas in **claims 21** and **27**, Sachweh et al (US 6284022B1) disclose HF (Col. 4, line 5).

As to halogen-containing gas stream being an exhaust gas from semiconductor manufacture in **claim 25**, Sachweh et al (US 6284022B1) disclose gas stream being suitable in principle all gas streams which have a carrier gas which is to be cleaned at the process temperature and which contains both gaseous and particulate contaminants which

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are to be removed (Col. 2, line 58-61). It would include the exhaust gas from semiconductor manufacture as claimed.

As to each water contacting step to be arranged to be generally counterflow relationship with the water in **claim 26**, Sachweh et al (US 6284022B1) disclose in countercurrent or cocurrent (Col. 5, line 42-45).

(3). Claims 8, 10-11, 13-17, 20, 23 and 28 are rejected under 35 U.S.C. 103(a) as being unpatentable over Sachweh et al (US 6284022B1) in view of Smith et al (EP-1023932A1).

As to one further treatment step of diluting the gas stream with a diluent gas in claim 8, gas stream being contacted with the diluent gas in a cyclone device in claim 10, Sachweh et al (US 6284022B1) do not teach the further treatment step of diluting in a cyclone as claimed.

However, Smith et al (EP 1023932A1) **teach** gas purifying cyclone (Title). The cleaning system comprises a cyclone for receiving the gas stream and separating the gas from the particles, where the cyclone processes means for the introduction of a diluent gas stream (Abstract).

The advantage of using a diluent gas in cyclone separator, in particular is to reduce the concentration of pyrophoric gases in noxious gas stream below their flammability limits ([0019]).

Therefore, it would have been obvious at time of the invention to add cyclone with diluent gas taught by Smith et al with the scrubbing tower in the method of Sachweh et al in order to attain the advantages. Moreover, further purification of product is obvious. MPEP §§ 2144.05.VII. In re Cofer, 354 F.2d 664, 148 USPQ 268 (CCPA 1966).

As to gas stream being contacted with the diluent gas in a cyclone device in **claim 22,** the disclosure of Sachweh et al, Smith et al is incorporated herein by reference, the most subject matters as currently claimed, have been recited in applicants' claim 10, and have been discussed therein.

As to step of contacting the gas stream with water, subsequently treating the gas stream in a cyclone device in which it is diluted with a diluent gas stream in a method of

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scrubbing a halogen-containing gas stream in **independent claim 11**, the disclosure of Sachweh et al, Smith et al is incorporated herein by reference, the most subject matters as currently claimed, have been recited in applicants' claims 7 and 10, and have been discussed therein.

As to step of withdrawing separately from the cyclone device solid particulate material and a treated gas stream in **independent claim 11**, Smith et al (EP 1023932A1) disclose the gas outlet 35 in the form of a tube set in to an upper wall 36 of the cyclone body 31 and a particle outlet 37 at the base of the conical portion 33 allowing particles to exit the body 31 under gravitational force and be collected at bottom of the body ([0039]).

As to diluent gas to be air in **claims 13** and **23**, Smith et al (EP 1023932A1) disclose the diluent gas conveniently being air ([0040]).

As to halogen-containing gas stream being an exhaust gas from semiconductor manufacture in **claim 14**, Sachweh et al (US06284022B1) disclose gas stream being suitable in principle **all gas streams** which have a carrier gas which is to be cleaned at the process temperature and which contains both gaseous and particulate contaminants which are to be removed (Col. 2, line 58-61). It would include the exhaust gas from semiconductor manufacture as claimed.

As to each water contacting step to be arranged to be generally counterflow relationship with the water in **claim 15**, Sachweh et al (US06284022B1) disclose in countercurrent or cocurrent (Col. 5, line 42-45).

As to gas stream flowing in a generally upward direction and water being caused to flow in a generally downward direction in **claim 16**, the figure 2 of Sachweh et al (US06284022B1) shows the features as claimed.

As to halogen-containing gas stream being a fluorine-containing gas stream in **claim 17**, Sachweh et al (US06284022B1) disclose HF, HCl or HBr (Col. 4, line 5).

As to the dilution unit in which treated gas to be diluted with a diluent gas in **claim 20**, the disclosure of Sachweh et al, Smith et al is incorporated herein by reference, the most subject matters as currently claimed, has been recited in applicants' claims 8 and 10 and has been discussed therein.

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**** ALTERNATIVELY, CLAIMS 1-3,5 ARE REJECTED IN THE FOLLOWING

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

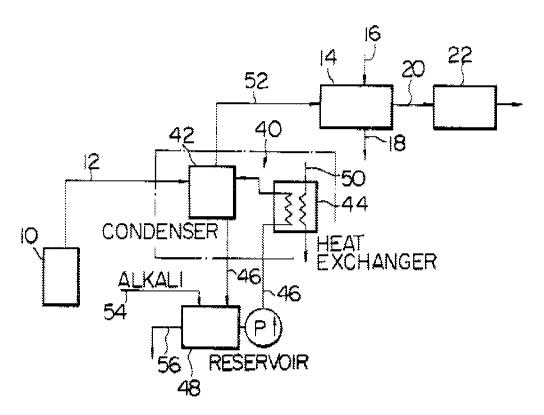
A person shall be entitled to a patent unless –

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- (4). Claims 1-3, 5 are rejected under 35 U.S.C. 102(b) as being anticipated by Fujikawa et al (US 4106918).

As to step of contacting the gas stream with water at a temperature of at least 30 °C in a method of scrubbing a halogen-containing gas stream in **independent claim 1**, gas stream being contact with water at a temperature of at least 35 °C in **claim 2**, water is in liquid phase in **claim 3**, gas stream to be contacted with water at a temperature of from 35 °C to 80 °C in **claim 5**, Fujikawa et al (US 4106918) disclose method of recovering fluorine from vapor of crude phosphoric acid solution (Title). To remove fluorides from a vapor generated by evaporation under reduced pressure of an aqueous solution of crude phosphoric acid containing fluorides, the vapor is at first brought into direct contact with cooling water to accomplish a partial condensation of vapor and transfer the fluorides almost entirely to the condensate (Abstract, line 1-6). As demonstrated in Example 1, the vapor was made to contact with a 37 °C cooling water which was supplied to the partial condenser 42 (Col. 4, line 67 – Col. 5, line 1). It is further shown in the Figure below.

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Fig. 3



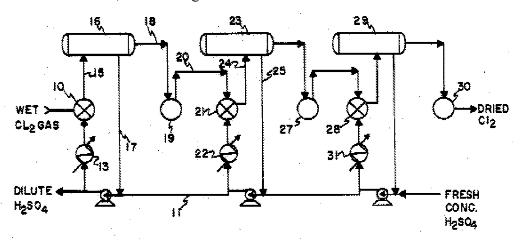
As to a further step treatment step comprising contacting the gas stream with water at a temperature of less than 30 °C in **independent claim 1**, Fujikawa et al (US 4106918) disclose the noncondensed portion of vapor to be brought into contact with a separate cooling water (Abstract, line 7-8). As demonstrated in Example 1, a 27 °C cooling water to be supplied to the condenser 14 (Col. 5, line 15-17).

(5). Claims 1-3, 5 are rejected under 35 U.S.C. 102(b) as being anticipated by Carron et al (US 4381190).

As to step of contacting the gas stream with water at a temperature of at least 30 °C; a further treatment step comprising contacting the gas stream with water at a temperature of less than 30 °C in a method of scrubbing a halogen-containing gas stream in **independent claim 1**, gas stream being contact with water at a temperature of at least

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35 °C in **claim 2**, water is in liquid phase in **claim 3**, gas stream to be contacted with water at a temperature of from 35 °C to 80 °C in **claim 5**, Carron et al (US 4381190) disclose process for drying and compressing chlorine gas (Title). It relates to the drying and compressing of gaseous chlorine using sulfuric acid (Col. 1, line 8-11). The drying and compressing are conducted in a liquid ring compressor (Col. 1, line 63-64). The sulfuric acid functions to dry the wet chlorine and functions as heat sink to cool the partially compressed gas which has been heated by the compression action (heat of compression) (Col. 2, line 65-68). The wet gas, at a temperature of from about 60-80 °C is maintained at a temperature of from 0 °C to about 130 °C during the drying and compression (Col. 3, line 12-15). As shown in the figure below, the diluted sulfuric acid would contain water in 1st, and 2nd stages.



Response to Arguments

(6). Applicant's arguments filed on 3/25/2009 have been fully considered but they are not persuasive.

In regards to the arguments that prior art Sachweh et al (US 6284022B1) fail to teach or even suggest a communication pathway for transport of the treated gas from the outlet of the hot wash chamber into the cold wash chamber (page 8, current Remarks). As the obviousness reasoning of duplication in parts applies, the communication pathway would be inherent, i.e. there must be some communication pathway between the series scrubbers.

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Applicant's arguments with respect to amended claim 1 have been considered but are most in view of the new ground(s) of rejection.

Although duplication in parts would not be applicable to the instant amended method claim 1, the obviousness reasoning of purifying an old product is still applicable to the amended instant claim 1. Examiner respectfully suggests Applicants to provide criticality results in order to overcome the obviousness rejections for instant claim 1.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to IVES WU whose telephone number is (571)272-4245. The examiner can normally be reached on 8:00 - 5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Duane Smith can be reached on 571-272-1166. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Examiner: Ives Wu Art Unit: 1797 Date: May 12, 2009

> /DUANE SMITH/ Supervisory Patent Examiner, Art Unit 1797